Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/735,914	SHIMIZU ET AL.
Examiner	Art Unit
Tony Ko	2878

	SEAR	CHED	
Class	Subclass	Date	Examiner
250	221, 214r, 214rc, 214c,	7/26/2005	тко
	-		

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
Same As	Above	7/26/2005	тко

SEARCH NO (INCLUDING SEARCH		)
	DATE	EXMR
See East Search History	7/26/2005	тко
Consulted with Primary Examiner Thanh X. Luu	7/26/2005	тко
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